

Search Notes

Application/Control No.

10/790,718

Examiner

EDMUND H. LEE

Applicant(s)/Patent under
Reexamination

CHANG, CHEN-CHUNG

Art Unit

1732

SEARCHED

Class	Subclass	Date	Examiner
264	263	6/13/2006	EHL
	250		
	261		
	328.1		
	259		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
264	263,261	6/13/2006	EHL
	328.1		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	6/13/2006	EHL
INVENTOR		